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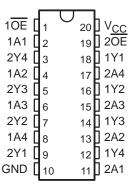
- Output Ports Have Equivalent 25-Ω Series Resistors, So No External Resistors Are Required
- State-of-the-Art EPIC-IIB™ BiCMOS Design Significantly Reduces Power Dissipation
- Typical V_{OLP} (Output Ground Bounce)
 1 V at V_{CC} = 5 V, T_A = 25°C
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK), and Plastic (N) and Ceramic (J) DIPs

description

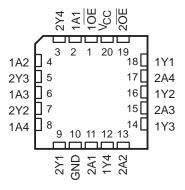
These octal buffers and line drivers are designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. Taken together with the 'ABT2240 and 'ABT2241, these devices provide the choice of selected combinations of inverting and noninverting outputs, symmetrical active-low output-enable (\overline{OE}) inputs, and complementary OE and \overline{OE} inputs. These devices feature high fan-out and improved fan-in.

The outputs, which are designed to sink up to 12 mA, include $25-\Omega$ series resistors to reduce overshoot and undershoot.

SN54ABT2244...J PACKAGE SN74ABT2244...DB, DW, N, OR PW PACKAGE (TOP VIEW)



SN54ABT2244 . . . FK PACKAGE (TOP VIEW)



To ensure the high-impedance state during power up or power down, $\overline{\text{OE}}$ should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN74ABT2244 is available in TI's shrink small-outline package (DB), which provides the same I/O pin count and functionality of standard small-outline packages in less than half the printed-circuit-board area.

The SN54ABT2244 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ABT2244 is characterized for operation from –40°C to 85°C.

FUNCTION TABLE (each buffer)

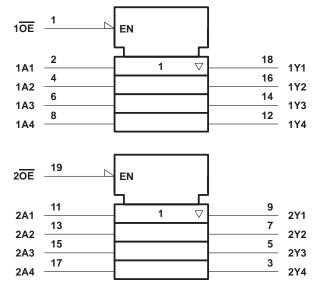
INPU	JTS	OUTPUT					
OE	Α	Υ					
L	Н	Н					
L	L	L					
Н	Χ	Z					

EPIC-IIB is a trademark of Texas Instruments Incorporated.



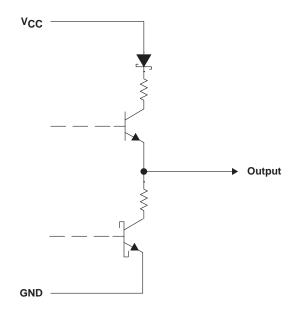
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logic symbol†

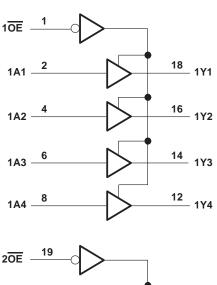


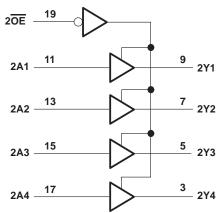
[†]This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

schematic of Y outputs



logic diagram (positive logic)





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}		0.5 V to 7 V
Input voltage range, V _I (except I/O ports) (see Note 1)		0.5 V to 7 V
Voltage range applied to any output in the high state or power-or	off state, V _O	. −0.5 V to 5.5 V
Current into any output in the low state, I _O		30 mA
Input clamp current, I _{IK} (V _I < 0)		–18 mA
Output clamp current, I _{OK} (V _O < 0)		–50 mA
Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note	2): DB package	0.6 W
	DW package	1.6 W
	N package	1.3 W
	PW package	0.7 W
Storage temperature range		-65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils, except for the N package, which has a trace length of zero. For more information, refer to the *Package Thermal Considerations* application note in the 1994 *ABT Advanced BiCMOS Technology Data Book*, literature number SCBD002B.

recommended operating conditions (see Note 3)

					SN74ABT2244		UNIT
			MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	4.5	5.5	V	
VIH	High-level input voltage	2		2		V	
V_{IL}	Low-level input voltage					0.8	V
VI	Input voltage	0	VCC	0	VCC	V	
loн	High-level output current		-24		-32	mA	
lOL	Low-level output current					12	mA
Δt/Δν	Input transition rise or fall rate	Outputs enabled		5		5	ns/V
Δt/ΔV _{CC}	Power-up ramp rate		200		200		μs/V
T _A	Operating free-air temperature		-55	125	-40	85	°C

NOTE 3: Unused or floating inputs must be held high or low.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER	TEST CONDITIONS			T _A = 25°C			SN54ABT2244		SN74ABT2244			
PARAMETER				MIN	TYP [†]	MAX	MIN	MAX	MIN	MAX	UNIT	
VIK	V _{CC} = 4.5 V,	I _I = -18 n			-1.2		-1.2		-1.2	V		
	$V_{CC} = 4.5 \text{ V}, \qquad I_{OH} = -3 \text{ mA}$			2.5			2.5		2.5		V	
\/a	$V_{CC} = 5 \text{ V}, \qquad I_{OH} = -3 \text{ mA}$			3			3		3			
VOH	V _{CC} = 4.5 V	I _{OH} = −24 mA		2			2				V	
	VCC = 4.5 V	$I_{OH} = -3$	2 mA	2*					2			
V _{OL}	$V_{CC} = 4.5 \text{ V},$	I _{OL} = 12	mA			0.8		0.8		0.8	V	
lį	$V_{CC} = 0 \text{ to } 5.5 \text{ V},$	$A^{I} = A^{CC}$	or GND			±1		±1		±1	μΑ	
lozpu	$V_{CC} = 0 \text{ to } 2.1 \text{ V},$	$V_0 = 0.5$			±50		±50		±50	μΑ		
lozpd	$V_{CC} = 2.1 \text{ V to } 0,$	$V_0 = 0.5 \text{ to } 2.7 \text{ V}, \overline{OE} = X$				±50		±50		±50	μΑ	
lozh	$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V}, V_O = 2.7 \text{ V}, \overline{OE} \ge 2 \text{ V}$					10		10		10	μΑ	
lozL	$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V}, V_O = 0.5 \text{ V}, \overline{OE} \ge 2 \text{ V}$					-10		-10		-10	μΑ	
l _{off}	$V_{CC} = 0$, $V_I \text{ or } V_O \le 4.5 \text{ V}$					±100				±100	μΑ	
ICEX	$V_{CC} = 5.5 \text{ V},$ $V_{O} = 5.5 \text{ V}$ Outputs high		Outputs high			50		50		50	μА	
IO [‡]	$V_{CC} = 5.5 \text{ V}, \qquad V_{O} = 2.5 \text{ V}$			-50	-100	-180	-50	-180	-50	-180	mA	
	V _{CC} = 5.5 V,		Outputs high		1	250		250		250	μΑ	
ICC	$I_{O} = 0$,		Outputs low		24	30		30		30	mA	
	$V_I = V_{CC}$ or GND		Outputs disabled		0.5	250		250		250	μΑ	
Δl _{CC} §	V _{CC} = 5.5 V, One input at 3.4 V, Other inputs at		Data	Outputs enabled			1.5		1.5		1.5	
		inputs	Outputs disabled			0.05		0.05		0.05	mA	
	V _{CC} or GND	Control inputs				1.5		1.5		1.5		
C _i	V _I = 2.5 V or 0.5 V				3						pF	
Co	V _O = 2.5 V or 0.5 V				8.5						pF	

^{*} On products compliant to MIL-STD-883, Class B, this parameter does not apply.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50$ pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 5 V, T _A = 25°C			SN54ABT2244		SN74ABT2244		UNIT	
			MIN	TYP	MAX	MIN	MAX	MIN	MAX		
t _{PLH}	А	Y	1	3.4	4.3	1	5.3	1	4.7	ns	
tPHL			1	4.5	5.3	1	6.8	1	5.6		
^t PZH	ŌĒ	Y	1.1	3.8	4.8	1.1	6.5	1.1	5.5	ns	
tpzL			2.1	6.3	7.3	2.1	10.2	2.1	8.3	115	
^t PHZ	ŌĒ	<u></u>	>	2.1	4.5	5.6	2.1	7	2.1	6.6	ns
t _{PLZ}		ı	1.7	4.3	5.3	1.7	7.4	1.7	5.8	115	

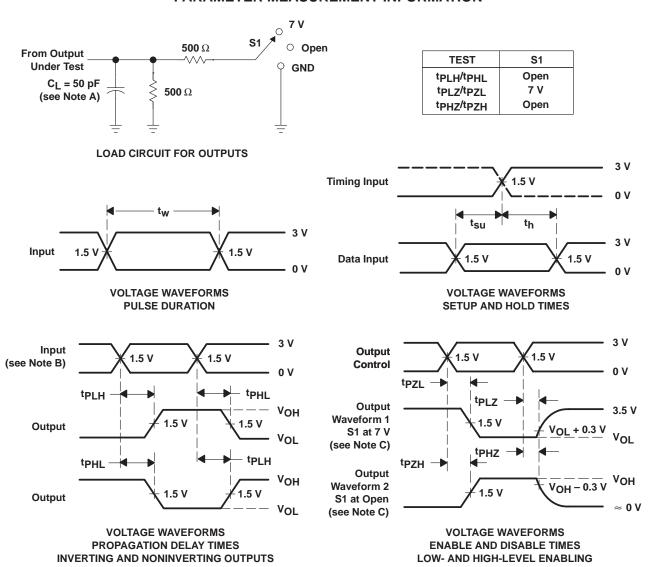
[†] All typical values are at $V_{CC} = 5 \text{ V}$.

[‡] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[§] This is the increase in supply current for each input that is at the specified TTL voltage level rather than VCC or GND.

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PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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